Notice of References Cited Application/Control No. O9/850,114 Examiner Djenane M Bayard Applicant(s)/Patent Under Reexamination TAKENAGA, TAKASHI Page 1 of 1

U.S. PATENT DOCUMENTS

*	0	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name .	Classification
	Α	US-6,505,203	01-2003	Adler, Robert M.	707/10
	В	US-			
	C	US-			
	D	US-		·	
	Е	US-			
	F	US-			
	G	US-		·	
	Η	US-			
	1	US-			
	J	US-			
	K	US-			
	اد	US-		·	
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	. Country	Name	Classification
	N	JP 11-259390	09-1999	Japan	nakano Toshiaki	G06F 13/00
	0					
	Р					•
	Q					
	R	•				
	s			t	•	
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	х	

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